


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576653	<b>Applicant(s)/Patent Under Reexamination</b>  CHENG ET AL.
	<b>Examiner</b>  CECILIA M JAISLE	<b>Art Unit</b>  1624

SEARCHED			
Class	Subclass	Date	Examiner
514	256, 269, 272, 274, 275	11/3/2009	C. Jaisle
544	297, 298, 309, 322, 323, 334, 335	11/3/2009	C. Jaisle

SEARCH NOTES		
Search Notes	Date	Examiner
STIC searched STN & Inventor Names	5/3/2008	C. Jaisle

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
514	256, 269, 272, 274, 275	11/3/2009	CJ
544	297, 298, 309, 322, 323, 334, 335	11/3/2009	CJ

/Cecilia M Jaisle/ Examiner.Art Unit 1624	
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